


<b>Search Notes</b> 	<b>Application/Control No.</b> 09866475	<b>Applicant(s)/Patent Under Reexamination</b> CHOI ET AL.
	<b>Examiner</b> M. Lee	<b>Art Unit</b> 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	175-194	7/1/08	ML

SEARCH NOTES		
Search Notes	Date	Examiner
east	7/1/08	ML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner